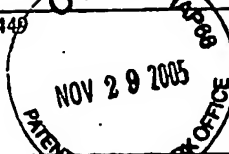


FORM PTO-1445		ATTY. DKT NO. 01-606	SER. NO. 10/811,800
		APPLICANT WATABE	
		FILING DATE March 30, 2004	GROUP 2632

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
E.L.	6,581,449	6/24/2003	Brown et al.		
	6,882,270	4/19/2005	Stewart et al.		
	6,062,072	5/16/2000	Mock et al.		
	6,565,599	4/08/2003	Derbyshire et al.		
	2004/0183665	9/23/2004	McClelland et al		

FOREIGN PATENT DOCUMENTS

TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
								Eng. Abstract	

* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER <i>Edny Lalbes</i>	DATE CONSIDERED <i>2/7/06</i>

FORM PTO-1449	ATTY. DKT NO.	01-606	SER. NO.	10/811800
	APPLICANT	WATABE		
	FILING DATE	March 30, 2004	GROUP	

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
E.L.	2002/0047779 A1 (Corresponding to JP-A-2002-67638 which is discussed page 1 of the spec.)	Apr. 25, 2002	Arita	✓	✓
E.L.	5,602,524 (Corresponding to JP-A-H07-507513 which is discussed page 2 of the spec.)	Feb. 11, 1997	Mock et al.	✓	✓

FOREIGN PATENT DOCUMENTS

								TRANSLATION	
		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
									Eng. Abstract
E.L.		WO 01/19626 A1	3/22/01	Europe		✓	✓		

- Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	<i>Edy. Labbers</i>	DATE CONSIDERED	9/16/05
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